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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Yan Borodovsky
 Serial No.: 10/681,031

Art Unit: 1756
 Examiner:

Filed : October 7, 2003

Assignee : Intel Corporation

Title : COMPOSITE OPTICAL LITHOGRAPHY METHOD FOR PATTERNING
 LINES OF SUBSTANTIALLY EQUAL WIDTH

Mail Stop Amendment

Commissioner for Patents
 P.O. Box 1450
 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Applicants call attention to the attached Information Disclosure Statement and documents listed on form PTO-1449.

This filing is being made before the receipt of a first Office action on the merits. No fee is required.

Each enclosed document listed on the herewith Form PTO-1449 was cited in one of the following documents issued in a foreign counterpart application not more than three months ago:

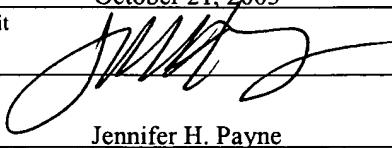
CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

October 21, 2005

Date of Deposit

Signature



Jennifer H. Payne

Typed or Printed Name of Person Signing Certificate

Applicant : Yan Borodovsky
Serial No. : 10/681,031
Filed : October 7, 2003
Page : 2 of 3

Attorney's Docket No.: 10559-881001 / P17483

- Japanese Office Action, dated September 12, 2005, for Application No. 093130386 (4 pages, including English translation);
- International Search Report, dated July 27, 2005, for Application No. PCT/US2004/034599 (4 pages); and
- International Search Report, dated July 27, 2005, for Application No. PCT/US2004/033066 (3 pages).

To the best knowledge of the undersigned, this is the first citation of these items in any communication from a foreign patent office in a counterpart foreign application.

Japanese Publication No. 2002-033265 is in the Japanese language. The abstract is being provided in the English language; no full translation is readily available.

Consideration of the foregoing and enclosures plus the return of a copy of the enclosed form PTO-1449 with the Examiner's initials in the left column per MPEP 609 are earnestly solicited along with an early action on the merits.

Applicant : Yan Borodovsky
Serial No. : 10/681,031
Filed : October 7, 2003
Page : 3 of 3

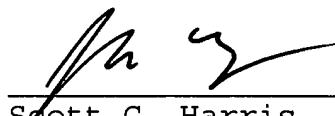
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Respectfully submitted, BY

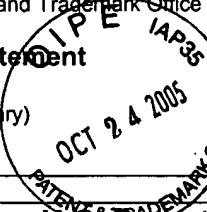
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10558486.doc

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 10559-881001	Application No. 10/681,031
Information Disclosure Statement by Applicant <small>(Use several sheets if necessary)</small> <small>(37 CFR §1.98(b))</small>		 Applicant Yan Borodovsky			
		Filing Date October 7, 2003	Group Art Unit 1756		

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2003/0091940	05/2003	Nakao			
	AB	5,705,321	01/1998	Brueck, et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
	AM	0 915 384	05/1999	Europe			
	AN	0 964 305	12/1999	Europe			
	AO	2002-33265	01/2002	Japan (w/abstract)			X
	AP	WO05/036273	04/2005	WIPO			
	AQ						

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AR	
	AS	
	AT	
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Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	